

1. Record Nr.	UNINA9910451906303321
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Titolo	Electron dynamics by inelastic X-ray scattering [[electronic resource] /] / Winfried Schulke
Pubbl/distr/stampa	Oxford ; ; New York, : Oxford University Press, 2007
ISBN	1-281-16006-7 9786611160067 0-19-152328-3 1-4356-2072-0
Descrizione fisica	1 online resource (606 p.)
Collana	Oxford series on synchrotron radiation ; ; 7
Disciplina	539.7/58
Soggetti	X-rays - Scattering Electrons - Inelastic scattering Electronic books.
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Description based upon print version of record.
Nota di bibliografia	Includes bibliographical references and index.
Nota di contenuto	Contents; List of important symbols; 1 Introductory survey; 2 Characteristic valence electron excitations; 3 Core-electron excitation (X-ray Raman scattering (XRS)); 4 The Compton scattering regime; 5 Resonant inelastic X-ray scattering (RIXS); 6 Theoretical foundation; Index
Sommario/riassunto	The book offers the first comprehensive review of experimental methods, theory, and successful applications of synchrotron radiation based inelastic X-ray scattering (IXS) spectroscopy, which enables the investigation of electron dynamics in condensed matter (correlated motion and excitation). - ; Knowledge of the dynamics of many-electron systems is of fundamental importance to all disciplines of condensed matter physics. A very effective access to electron dynamics is offered by inelastic X-ray scattering (IXS) spectroscopy. The double differential scattering cross section for IXS is directly